

<p>Search Notes</p> 	<p>Application/Control No.</p> <p>10/563,656</p> <p>Examiner</p> <p>KAGNEW H. GEBREYESUS</p>	<p>Applicant(s)/Patent under Reexamination</p> <p>ANDERSON ET AL.</p> <p>Art Unit</p> <p>1656</p>			
SEARCHED		SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner	DATE	EXMR
INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		